

IEEE Xplore® for UK academic libraries

Rachel Berrington

Senior Manager, IEEE Client Services

USTLG Meeting, University of Cambridge, 28 Nov. 2011



Today's Topics

- About IEEE
- IEEE Content Update
- Recent IEEE Xplore Enhancements
- What's Ahead for 2012 and Beyond
- Ongoing support from the Client Services Website

About the IEEE

- World's largest technical membership association with more than 400,000 members (80,000 students) in over 160 countries
- Not for profit society that “fosters technological innovation and excellence for the benefit of humanity.”
- Core areas of activity
 - Membership
 - Conferences
 - Standards
 - Education
 - Publishing



Jonathan Chew, former UCLA student branch chair (left) and William Lu, UCLA project manager, in NJ to attend the IEEE UPP Leadership Summit

IEEE Humanitarian Activities

- In recent years, IEEE allocating more resources than ever to humanitarian efforts
- Influence from IEEE Student Groups and GOLD (Graduates of the Last Decade)



Moshe Kam
2011 IEEE
President



Recent Humanitarian Projects

Classification	Examples
Field Projects	<ul style="list-style-type: none">• IEEE EPICS Program
Information Dissemination and Networking	<ul style="list-style-type: none">• Publishing in Humanitarian Engineering• Humanitarian Technology Challenge• Engineering for Change
Organizing the Community	<ul style="list-style-type: none">• Global Humanitarian Technology Conference• IEEE Presidents Change the World Competition• Xtreme Programming

IEEE Covers All Areas of Technology

More than just electrical engineering & computer science

renewable energy

AEROSPACE

communications

optics

INFORMATION TECHNOLOGY

IMAGING

semiconductors

biomedical engineering

electronics

nanotechnology

wireless
broadband

CIRCUITS

COMPUTING



IEEE Quality Makes an Impact

Journal Citation Report Results, by Impact Factor

IEEE publishes:

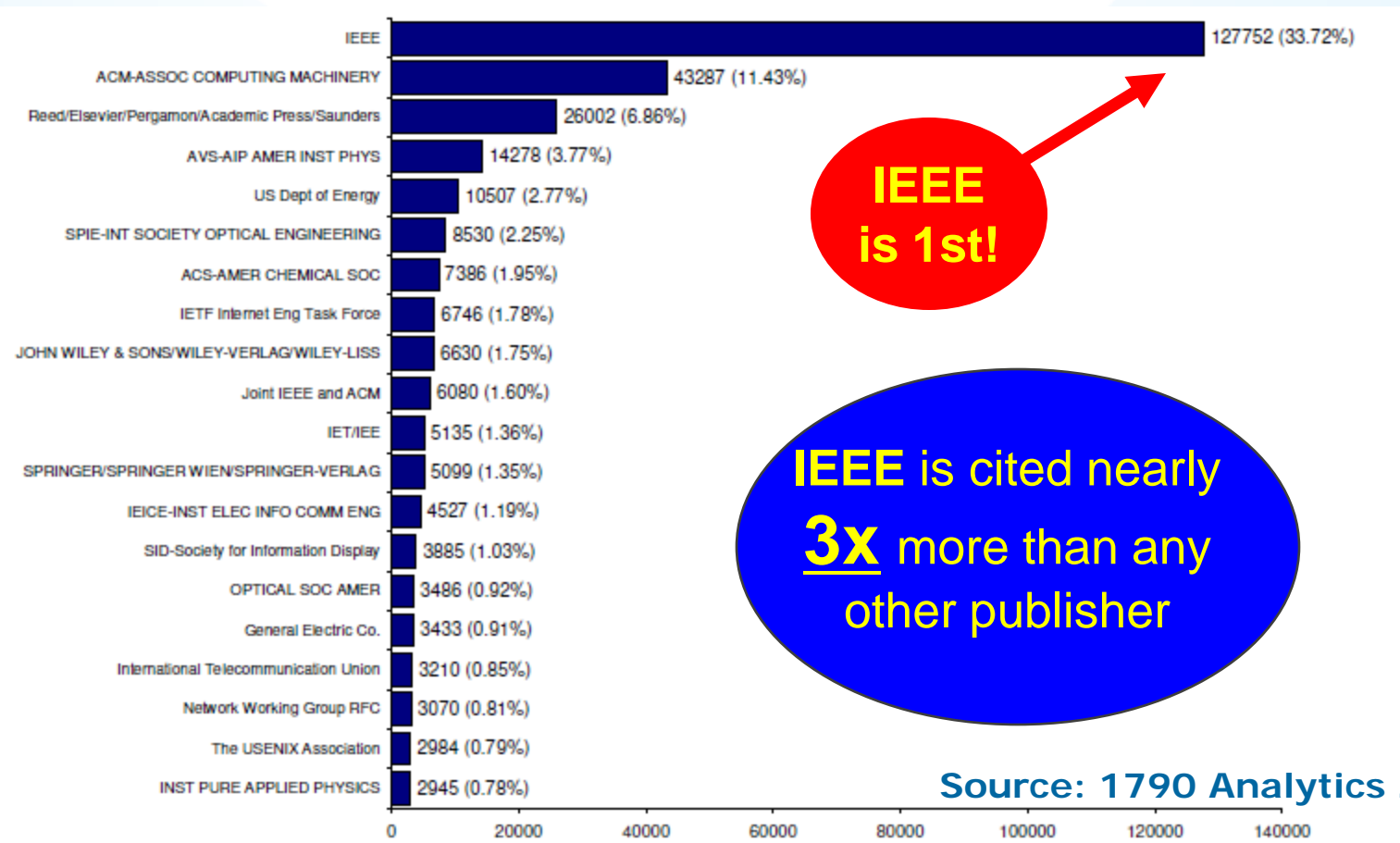
- **#1** journal in Electrical and Electronic Engineering
- 16 of the top 20 journals in Electrical and Electronic Engineering
- 8 of the top 10 journals in Telecommunications
- 6 of top 10 journals in Computer Science, Hardware & Architecture
- 3 of the top 5 journals in Computer Science, Cybernetics
- 3 of the top 5 journals in Automation & Control Systems
- # 1 in Artificial Intelligence
- # 1 in Transportation Technology
- # 3 in Imaging Science
- # 3 in Robotics
- # 5 in Biomedical Engineering



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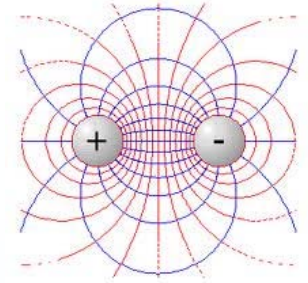
Technology Patent References to STM Publishers



- U.S. patent references from the top 25 patenting organizations in 2011 to top publishers
- Based on number of references to papers/standards/conferences from 1997-2010

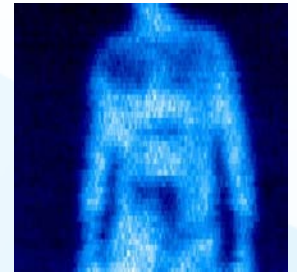
New IEEE Journals for 2012

- IEEE Consumer Electronics Magazine
- IEEE Electromagnetics Compatibility Magazine
- IEEE Wireless Communications Letters
- IEEE RFID Virtual Journal
- IEEE RFIC Virtual Journal



New IEEE Journals for 2011

- IEEE Journal on Emerging and Selected Topics in Circuits and Systems
- IEEE Journal of Photovoltaics
- IEEE Transactions on Terahertz Science and Technology



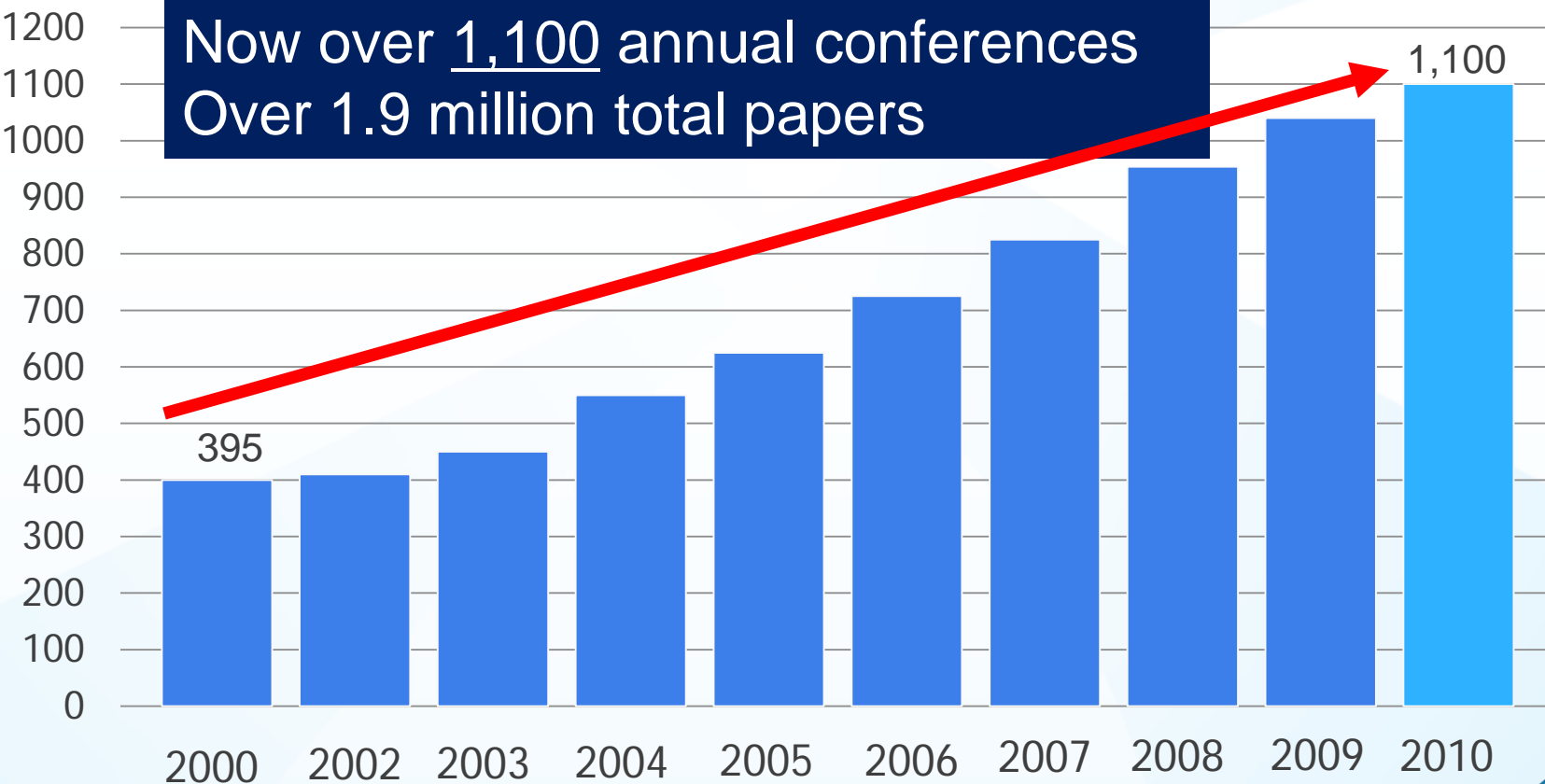
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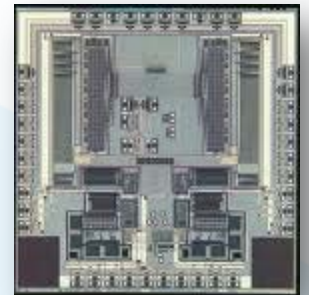
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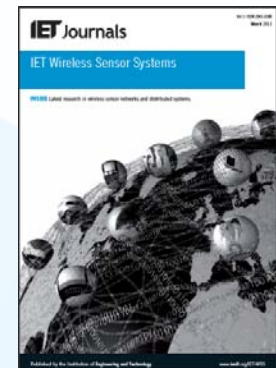
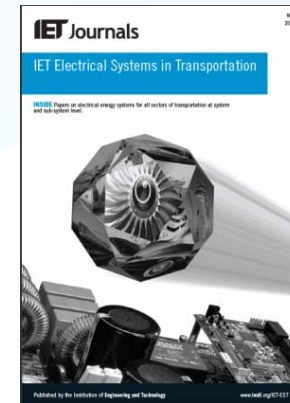
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- Goal for IEEE *Xplore* to become the technology portal of choice worldwide
- IEEE *Xplore* now hosts select content from other leading society publishers



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Sources: * ISI JCR 2011 ** 1790 Analytics 2010

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The milestone document, "Protecting Smart Grid Automation Systems Against Cyberattacks," is an early access article published in *IEEE Transactions on Smart Grid*.

Authors of the paper are Dong Wei, and Yan Lu, two IEEE members from Siemens; Mohsen Jafari, an IEEE member from Rutgers University; Paul M. Skare, an IEEE member from Pacific Northwest National Laboratory, and Kenneth Rohde from the Cyber Security Research and Development at the Idaho National Laboratory.

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Publication Year

☐ Single Year ☒ Range



From: 1966

To: 2011

Author

Search for Author

- ☐ Wenbo Wang (6)
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☐ [Overcoming interference in spatial multiplexing MIMO cellular networks](#)

Andrews, J.G.; Wan Choi; Heath, R.W.;

[Wireless Communications, IEEE](#)

Volume: 14 , [Issue: 6](#)

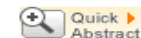
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IEEE JOURNALS

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☐ [Location-based compromise-tolerant security mechanisms for wireless sensor networks](#)

Yanchao Zhang; Wei Liu; Wenjing Lou; Yuguang Fang;

[Selected Areas in Communications, IEEE Journal on](#)

Volume: 24 , [Issue: 2](#)

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CITED BY IEEE

1. Doncel, V.R., Nikolaidis, N., Pitas, I., "An Optimal Detector Structure for the Fourier Descriptors Domain Watermarking of 2D Vector Graphics", *Visualization and Computer Graphics, IEEE Transactions on*, On page(s): 851 - 863, Volume: 13 Issue: 5, Sept.-Oct. 2007
[Abstract](#) | Full Text: [PDF](#) (2537KB)
2. Konstantinides, J.M., Mademlis, A., Daras, P., Mitkas, P.A., Strintzis, M.G., "Blind Robust 3-D Mesh Watermarking Based on Oblate Spheroidal Harmonics", *Multimedia, IEEE Transactions on*, On page(s): 23 - 38, Volume: 11 Issue: 1, Jan. 2009
[Abstract](#) | Full Text: [PDF](#) (1721KB)

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- ☐ IEEE Std 1680-2009 (Revision of IEEE Std 1680-2006) - Redline (1)

Subject

- ☐ Communication, Networking & Broadcasting (1)
- ☐ Computing & Processing (Hardware/Software) (1)
- ☐ Components, Circuits, Devices & Systems (1)

Standard Status

- ☐ Active (112)
- ☐ Active Unapproved Draft (17)
- ☐ Archived (60)
- ☐ Archived Approved Draft (16)
- ☐ Archived Unapproved Draft (24)
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- ☐ [IEEE Standard for Environmental Assessment of Electronic Products - Redline](#)



Quick Abstract

[IEEE Std 1680-2009 \(Revision of IEEE Std 1680-2006\) - Redline](#)

Publication Year: 2010 , Page(s): 1 - 17

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The environmental performance criteria of the IEEE 1680 family of standards are intended to define a measure of environmental leadership in: the design and manufacture of ~~personal-computer~~ electronic products ~~that are marketed to institutions~~; the delivery of specified services that are associated with the sale of the product ~~to institutions~~; and in associated corporate performance characteristics.

This family of standards is defined with the intention that the criteria are technically feasible to achieve, but that only products demonstrating the leading environmental performance currently available in the marketplace would meet them at the time of their adoption. As the environmental performance of products that are available in the marketplace improves, it is intended that the criteria will be updated and revised to set a higher performance standard for leadership products.

This standard is intended to serve as a baseline for further environmental standards for additional electronic products to be developed in the future. References to IEEE Std 1680 likewise reference, unless otherwise specified, the individual product standards in the IEEE 1680 family of standards.

1.3 Application

The environmental performance criteria are contained in the standards that are members of this IEEE 1680 family of standards. The principles and procedures identified in Clause 1 apply to ~~notebook personal computers, desktop personal computers, and personal computer monitors.~~ The principles and procedures identified in Clause 1, Clause 2, and Clause 3 apply to personal-computer electronic products and will apply to future standards developed for additional electronic products.

Different configurations of a product, as defined in the standards in this family, may include options for processors, memory, hard disks, etc. A product, for the purpose of this family of standards, is every configuration that could be offered in a specific marketing model and chassis type. If ~~there is a~~ specific ~~configuration within a marketing model and chassis type that would change~~ configurations do not meet the environmental performance substantially, especially if that configuration would no longer meet a criterion criteria as declared, then the manufacturer ~~could not claim conformance to this Standard for that configuration, even if the same model in other configurations did conform to this Standard.~~ The manufacturer shall clearly report such special to the Product Registration Entity which configurations ~~that do not conform to meet the Standard to the Product Registration Entity~~ criteria as declared.

A product includes ~~a desktop computer, a notebook computer or monitor,~~ an electronic product and all the peripherals that are integral to its operation. For example, the desktop computer together with the keyboard, the mouse, and the power cord would be a product.

1.4 Conformance with the IEEE 1680 family of standards

A manufacturer may designate one or more specific geographic regions, or countries, for which a product declaration is applicable. In order to conform to this Standard be conformant in a designated region or country, each unit of a the product that is sold in that region or country must satisfy all of the applicable

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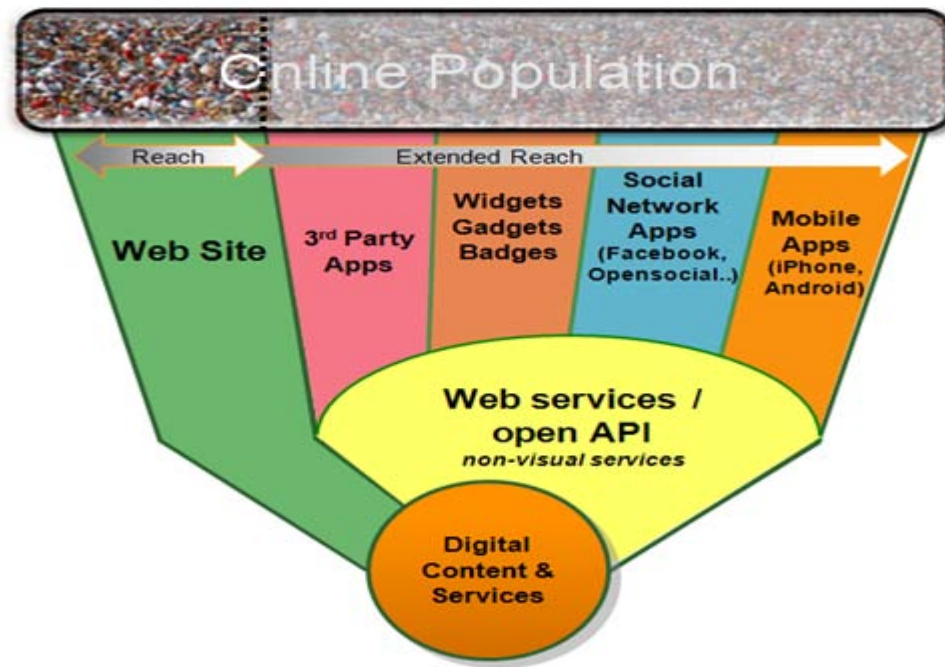
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